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NSAI Standards

Irish Standard
I.S. EN 60749-31:2003

Semiconductor devices - Mechanical and climatic test methods - Part 31: Flammability of plastic-encapsulated devices (internally induced)

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I.S. EN 60749-31:2003

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1 Swift Square,	F +353 1 807 3838	T +353 1 857 6730
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EUROPEAN STANDARD **EN 60749-31**

NORME EUROPÉENNE

EUROPÄISCHE NORM June 2003

ICS 31.080.01

English version

Semiconductor devices - Mechanical and climatic test methods Part 31: Flammability of plastic-encapsulated devices (internally induced)

(IEC 60749-31:2002)

Dispositifs à semiconducteurs - Méthodes d'essais mécaniques et climatiques Partie 31: Inflammabilité des dispositifs à encapsulation plastique (cas d'une cause interne d'inflammation) (CEI 60749-31:2002)

Halbleiterbauelemente - Mechanische und klimatische Prüfverfahren Teil 31: Entflammbarkeit von Bauelementen in Kunststoffgehäusen (Selbstentzündung) (IEC 60749-31:2002)

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

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The text of the International Standard IEC 60749-31:2002 was approved by CENELEC as EN 60749-31 on 2002-09-24.

The text of this International Standard was reproduced from IEC 60749:1996, chapter 4, subclause 1.1 without change. Therefore, it has not been submitted to vote a second time and is still based on document 47/1394/FDIS.

The following dates were fixed:

– latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2004-01-01

– latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2005-10-01

Each test method governed by this standard and which is part of the series is a stand-alone document, numbered EN 60749-2, EN 60749-3, etc. The numbering of these test methods is sequential, and there is no relationship between the number and the test method (i.e. no grouping of test methods). The list of these tests will be available in the CENELEC internet site and in the catalogue.

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NORME INTERNATIONALE

INTERNATIONAL STANDARD

CEI
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60749-31

Première édition
First edition
2002-08

Dispositifs à semiconducteurs – Méthodes d'essais mécaniques et climatiques –

Partie 31: Inflammabilité des dispositifs à encapsulation plastique (cas d'une cause interne d'inflammation)

Semiconductor devices – Mechanical and climatic test methods –

Part 31: Flammability of plastic-encapsulated devices (internally induced)

Numéro de référence
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